

<b>Notice of References Cited</b>	Application/Control No. 10/817,094		Applicant(s)/Patent Under Reexamination GAIKWAD ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0064281	04-2004	Kim, Hea Joung	702/107
*	B	US-2004/0063412	04-2004	Kim et al.	455/226.2
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